Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/669,729	LEE ET AL.	
Examiner	Art Unit	_
Gims S. Philippe	2621	•

SEARCHED			
Class	Subclass	Date	Examiner
375	240.16 240.24 240.17	4/4/2007	GP
382	233		
	261		
	268		
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Text searched; class/subclass	4/4/2007	GP